## Notice of References Cited Application/Control No. 09/378,669 Examiner Polin Chieu Applicant(s)/Patent Under Reexamination LIN ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,385,389	05-2002	Maruyama et al.	386/95
	В	US-6,381,398	04-2002	Yamauchi et al.	386/52
	O	US-6,173,113	01-2001	Okada et al.	386/95
	D	US-6,160,952	12-2000	Mimura et al.	386/95
	ш	US-5,745,643	04-1998	Mishina, Masamitsu	386/106
	F	US-5,621,840	04-1997	Kawamura et al.	386/68
	G	US-5,276,665	01-1994	Aoki et al.	369/53.2
	Н	US-6,434,326	08-2002	Kondo et al.	386/125
	I	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			11/2

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					·
	s					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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